

<b>Notice of References Cited</b>	Application/Control No. 10/031,575	Applicant(s)/Patent Under Reexamination ONG, THIAN LIANG	
	Examiner Akash Saxena	Art Unit 2128	Page 1 of 3

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,031,545	02-2000	Ellenby et al.	345/632
	B	US-6,080,063	06-2000	Khosla, Vinod	463/42
	C	US-5,526,479	06-1996	Barstow et al.	345/473
	D	US-5,462,275	10-1995	Lowe et al.	463/43
	E	US-5,742,521	04-1998	Ellenby et al.	702/127
	F	US-2002/0080279	06-2002	Wang et al.	348/584
	G	US-5,751,612	05-1998	Donovan et al.	703/6
	H	US-5,745,126	04-1998	Jain et al.	382/154
	I	US-5,564,698	10-1996	Honey et al.	473/570
	J	US-6,246,468	06-2001	Dimsdale, Jerry	702/167
	K	US-6,113,504	09-2000	Kuesters, Eckhard H.	473/152
	L	US-6,020,851	02-2000	Busack, Andrew J.	342/457
	M	US-6,401,033	06-2002	Paulauskas et al.	701/200

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>	Application/Control No. 10/031,575	Applicant(s)/Patent Under Reexamination ONG, THIAN LIANG	
	Examiner Akash Saxena	Art Unit 2128	Page 2 of 3

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,616,529	09-2003	Qian et al.	463/1
	B	US-2002/0049507	04-2002	HAMEEN-ANTTILA, TAPIO	700/92
	C	US-2002/0132211	09-2002	August et al.	434/247
	D	US-5,153,836	10-1992	Fraughton et al.	701/301
	E	US-5,507,485	04-1996	Fisher, Donald	473/407
	F	US-5,623,414	04-1997	Misra, Pratap N.	701/207
	G	US-5,914,685	06-1999	Kozlov et al.	342/357.12
	H	US-6,006,021	12-1999	Tognazzini, Bruce	703/1
	I	US-6,126,548	10-2000	Jacobs et al.	463/42
	J	US-6,195,090	02-2001	Riggins, III, A. Stephen	725/139
	K	US-6,324,474	11-2001	Beisner et al.	701/215
	L	US-6,785,667	08-2004	Orbanes et al.	707/1
	M	US-6,940,538	09-2005	Rafey et al.	348/157

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>	Application/Control No. 10/031,575	Applicant(s)/Patent Under Reexamination ONG, THIAN LIANG	
	Examiner Akash Saxena	Art Unit 2128	Page 3 of 3

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0091017	07-2002	Kuesters, Eckhard H.	473/353
	B	US-2002/0098913	07-2002	Goldman, Cheryl	473/353
	C	US-2003/0014275	01-2003	Bearden et al.	705/1
	D	US-2003/0038892	02-2003	Wang et al.	348/461
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.